

Component Title:

Power Mosfet STRH100N10 - STRH40N6 - STRH100N6 - STRH8N10 - STRHMF16N20

Executive Member: CNES

Date: 04/04/2024

Page 1 Appl. No.

	E	xecutive Member:	CNES		Da	ate: 04/04/2024	303F-rev2	2	
Components (including	ng series and families) s	submitted for Extension	of Qualification	Approval:				1	
ESCC COMPONENT NO.	VARIANTS	RANGE OF CO	MPONENTS	BASED ON)	TEST VEHICLE / S	COMPONENT SIMILAR		
5205/021	01, 02	TO-254AA		STRH100N1	0	ID33637009Z3			
5205/022	01, 02	TO-254AA							
5205/023	01, 02	SMD.5		STRH8N10	i	ID33718004Z6			
5205/024	01, 02	SMD.5		STRH40N6					
5205/034	01, 02	SMD.5		STRHMF16N	120	ID33018001ZX			
Component Ma	·	Location of Ma	nufacturing Plan	t(s) 3				4	
STMicroelectronics		3, rue de Suisse BP4199, 35041 Rennes Cedex Date of original qualification approval: Date: 14/10/2010 Certificate Ref No. 303							
	5			6				7	
ESCC Specifications Maintenance of qualit Generic: 5000	used for	Deviations to LVT testing and Detail Specification used: No Yes (supply details in Box 15) Qualification Extension Report reference and date: STRH100N10HYG_33637009Z3_Chart F4 23/C STRH8N10SG_33718004Z6_Chart F4 18/05/2:							
Detail(s): 5205/021							Evaluation (CA, Power durance, temperature Qualification_Full cha SEE and TID test	е	
					33945	6004ZD Sg1 DC 2121A.		Ι.	
			r re		-P	. // t- F000 lists d.E.		8	
					plication	(those to ESCC listed fin			
Project Name	Testing Level	LAT		Date code		Quantity	Delivered		
					i				
						E V L ONE			
PID changes since st	aπ of qualification	9	Current PID \	ventied by:		F. Vacher, CNES		10	
None				not a great production		ame of Excutive Represer			
Minor* ⊠			Ref No:	Ref No: 8097046 (generic) Rev 37 & 8212222 (specific Mosfet) rev 16					
Major* □	*Provide details in box:		Issue: Rev Date:	03/05/2023	Date:				
	27 1007		********	507 26645650000		12-24	L	11	
Current Manufacturin	g facilities surveyed by:	7 <u></u>	JB Sauv	replane, CNES	on	12/	07/2023		
		(Name	e of Executive Re	epresentative)		(Date)		
Satisfactory:	Yes 🖂	No □ Exp	olain						
Report Reference:	CR-Visite Juillet 20	023							

Component title:

Power Mosfet STRH100N10 – STRH40N6 – STRH100N6 – STRH8N10 – STRHMF16N20

Executive Member: CNES

Date: 04/04/2024

Page 2 Appl. No.

303F-rev2

										545 C. C. C.	1000
Failure A	nalysis, DPA, NCCS a	available:		Yes		No	×	(Supply data)			12
Ref. No	's and purposes:										
that the (except CNES a	appropriate docum as stated in box 15 as the responsible 6	nentation has been 5;) - that the repor	n evaluated; ts and data a	- that ful are availa	l compli able at t	iance to a	all ESC Execu	mation is correct; - C requirements is e utive and therefore a ed to the component	applies on behalf of (s) listed herein. Giana.	ndrea Qua	13
Date:	04/04/2024									QUADRI xecutive Coordinator)	
Extensi	ation of Boxes abo ion of the qualified accomplished for a	range to SMD.5 w	vith Sn/PB fir -rev.1, STPS	nish varia 660A150	ants for device	ESCC do	etailed e packa	Specifications 5205/ age with tin lead finis	/023 : this is based or sh)	a rational of similarity	14 (test

Power Mosfet STRH100N10 - STRH40N6 - STRH100N6 - STRH8N10 - STRHMF16N20 Component title:

Executive Member:

Date: 04/04/2024 CNES

Page 3

Appl. No.

303F-rev2

Non com	pliance to ESCC requirements:						15
No.:	Specification		Paragraph			Non compliance	
		1					
		- 17					
Additiona	I tasks required to achieve full complia	nce for ESCC qualific	ation or rationale for	acceptability of			16
noncomp	liance:						
Executive	e Manager Disposition						17
							L.
Action / R							
						0.	
					B	X/	
Date:				9	D. Cohada II	and of the Dead and	Annurance and
					B. Schade: H Safety D	ead of the Product epartment	Assurance and



Power Mosfet STRH100N10 – STRH40N6 – STRH100N6 – STRH8N10 – STRHMF16N20 Component Title:

Executive Member: CNES 04/04/2024 Date:

Page 4 Appl. No.

303F-rev2

18

ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

Tests conducted in compliance with:

ESCC 5000 generic specification; Chart F4 (for ESCC/QPL parts); or PID-TFD (for ESCC/QML parts)

or PID-TFD

Tests vehicle identification/description:

STRH100N10HYG_33637009Z3_DC2044 Full Chart F4	STRHMF16N20_33018001ZX_DC2037 Full chart F4
STRH8N10SG_33718004Z6_DC2131 Full Chart F4	

Detail Specification reference:

		Tick		Date			
Chart F4	Test	when done	Conditions	Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
	Mechanical shock	×	MIL-STD-750 TM2016	2044 2131 2037	15 +15 +15	0	
	Vibration	×	MIL-STD-750 TM2056	2044 2131 2037	15 +15 +15	0	
	Constant acceleration	\boxtimes	MIL-STD-750 TM2006	2044 2131 2037	15 +15 +15	0	
dno	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
al Subgr	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
nanica	External Visual	×	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
Environmental/Mechanical Subgroup	Thermal shock		MIL-STD-750 TM1056	Click here to enter text.			Only applicable to axial lead glass diodes
nmer	Temperature Cycling	⊠	MIL-STD-750 TM1051	2044 2131 2037	15 +15 +15	0	
inviro	Moisture Resistance	×	MIL-STD-750 TM1021	2044 2131 2037	15 +15 +15	0	
Ш	Seal Fine leak Gross leak	×	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
	Electrical Measurement	×	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
	External Visual	\boxtimes	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
Q	Operating Life		ESCC 5000 Para. 8.19	2044 2131 2037	15 +15 +15	0	
Subgro	Electrical Measurement	⊠	Intermediate and End- Point Electrical Measurements	2044 2131 2037	15 +15 +15	0	
Endurance Subgroup	Seal Fine leak Gross leak	⊠	MIL-STD-750 TM1071	2044 2131 2037	15 +15 +15	0	
E	External Visual Inspection	×	ESCC Basic Spec 20500	2044 2131 2037	15 +15 +15	0	
4	Permanence of Marking		ESCC Basic Spec 24800				Not applicable on Laser marking
ipabili up	Terminal Strength	×	ESCC 5000 Para. 8.18	2044 2131 2037	5 + 5 +5	0	
mbly Capa Subgroup	Internal Visual		ESCC Basic Spec 20400	2044 2131 2037	5 + 5 +5	0	
Assembly Capability Subgroup	Bond Strength	☒	MIL-STD-750 TM 2037	2044 2131 2037	3 + 3 + 3	0	
₹	Die Shear	×	MIL-STD-750 TM 2017	2044 2131 2037	3+3+3	0	



Power Mosfet STRH100N10 - STRH40N6 - STRH100N6 - STRH8N10 - STRHMF16N20 Component Title:

Date: 04/04/2024

Page 6 Appl. No.

303F-rev2

Ch art F4	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	N° of Rejects	Comments if not performed. Comments on Rejection
Tig .							
ddition							
8							

CNES

Executive Member:



Box 22

Additional Comments.

APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL

Power Mosfet STRH100N10 - STRH40N6 - STRH100N6 - STRH8N10 - STRHMF16N20 Component title:

Executive Member: CNES Date: 15/03/2023 Page 7

Appl. No. 3 303F-rev2

1	NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL
ENTRIES	
Form heading	shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.
Box 1	shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.
Box 2; 3 and 4	As per QPL entry; otherwise, an explanation of the changes must be supplied.
Box 5	Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.
Box 6	Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.
Box 7	Must reference the report(s) supplied in support of the application.
Box 8	Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.
Box 9	If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.
Box 10	Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.
Box 11	This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.
Box 12	Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.
Box 13	Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.
Box 14	To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.
Box 15	Fill in Table as requested.
Box 16	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.
Box 17	All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.
Box 18	Fill in Table as requested.
Box 19	Confidential Details of PID changes including those of a confidential nature, shall be provided.
Box 20	State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 16 each nonconformance shall be sequentially numbered. If relevant state 'None'.
Box 21	Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.